

DK-125564-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

Cellular Gateway

Lantronix, Inc. 7535 Irvine Center Drive, Suite 100, Irvine, CA 92618 USA

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Sunshine Global Circuits Co., Ltd. B Building No. 32 Nanhuan Road, Shangxing 2nd Industrial zone Xinqiao community, Baoan District, SHENZHEN GUANGDONG 518125,

☐ Additional Information on page 2

10.8-60 Vdc, 0.5 A (Optional)



G526XXXXX

(X can be 0-9, A-Z, a-z, blank or dash)

Additionally evaluated to: EN 62368-1:2014, EN 62368-1:2014/A11:2017 National Differences specified in the CB Test Report.

☐ Additional Information on page 2

IEC 62368-1:2014

WL-ITAV-21L2107-A0 issued on 2022-03-22

This CB Test Certificate is issued by the National Certification Body



- □ UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
 ☑ UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
 □ UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
 □ UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2022-03-24

Signature:

Jan-Erik Storgaard